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Confirmation Letter

To,
Omprakash Rathore
Published in : Volume 9 | Issue 5 | 2022-05-27



Subject: Publication of paper at International Journal of Emerging Technologies and Innovative Research .

Dear Author,

With Greetings we are informing you that your paper has been successfully published in the International Journal of Emerging Technologies and Innovative Research (ISSN: 2349-5162). Following are the details regarding the published paper.

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Authors : Omprakash Rathore

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